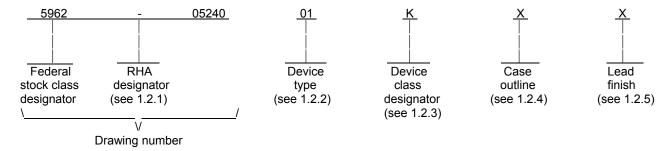
							R	REVISI	ONS										
LTR	DESCRIPTION							DA	TE (YI	R-MO-	·DA)	APPROVED							
Α	Table II, add note to Group C end-point test parameter boilerplate paragraphsgz						ers. Update 11-02-10			Charles F. Saffle									
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1. SCOPE

Device class

- 1.1 <u>Scope</u>. This drawing documents five product assurance classes as defined in paragraph 1.2.3 and MIL-PRF-38534. A choice of case outlines and lead finishes which are available and are reflected in the Part or Identifying Number (PIN). When available, a choice of radiation hardness assurance levels are reflected in the PIN.
 - 1.2 PIN. The PIN shall be as shown in the following example:



- 1.2.1 <u>Radiation hardness assurance (RHA) designator</u>. RHA marked devices shall meet the MIL-PRF-38534 specified RHA levels and shall be marked with the appropriate RHA designator. A dash (-) indicates a non-RHA device.
 - 1.2.2 Device type. The device type identify the circuit function as follows:

Device type	Generic number	<u>Circuit function</u>
01	LS2805S	DC/DC converter, 30 W, 5 V output

1.2.3 <u>Device class designator</u>. This device class designator shall be a single letter identifying the product assurance level. All levels are defined by the requirements of MIL-PRF-38534 and require QML Certification as well as qualification (Class H, K, and E) or QML Listing (Class G and D). The product assurance levels are as follows:

2 3 1.00 0.000	
К	Highest reliability class available. This level is intended for use in space applications.
Н	Standard military quality class level. This level is intended for use in applications where non-space high reliability devices are required.
G	Reduced testing version of the standard military quality class. This level uses the Class H screening and In-Process Inspections with a possible limited temperature range, manufacturer specified incoming flow, and the manufacturer guarantees (but may not test) periodic and conformance inspections (Group A, B, C, and D).
E	Designates devices which are based upon one of the other classes (K, H, or G) with exception(s) taken to the requirements of that class. These exception(s) must be specified in the device acquisition document; therefore the acquisition document should be reviewed to ensure that the exception(s) taken will not adversely affect system performance.
D	Manufacturer specified quality class. Quality level is defined by the manufacturers internal, QML certified flow. This product may have a limited temperature range.

Device performance documentation

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 2

1.2.4(Case outline.	The case outline	are as	designated in	MIL-STD-	-1835 and	as follows:
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Outline letter	Descriptive designator	<u>Terminals</u>	Package style
Χ	See figure 1	8	Flanged package

1.2.5 Lead finish. The lead finish shall be as specified in MIL-PRF-38534.

1.3 Absolute maximum ratings. 1/

1.4 Recommended operating conditions.

Input voltage range	+18 V dc to +40 V dc
Output power	≤ 30 W
Case operating temperature range (T _C)	-55°C to +85°C

2. APPLICABLE DOCUMENTS

2.1 <u>Government specification, standards, and handbooks</u>. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATIONS

MIL-PRF-38534 - Hybrid Microcircuits, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883 - Test Method Standard Microcircuits.

MIL-STD-1835 - Interface Standard Electronic Component Case Outlines.

DEPARTMENT OF DEFENSE HANDBOOKS

MIL-HDBK-103 - List of Standard Microcircuit Drawings. MIL-HDBK-780 - Standard Microcircuit Drawings.

(Copies of these documents are available online at https://assist.daps.dla.mil/quicksearch/ or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

^{1/} Stresses above the absolute maximum ratings may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME		REVISION LEVEL	SHEET
COLUMBUS, OHIO 43218-3990		A	3

3. REQUIREMENTS

- 3.1 <u>Item requirements</u>. The individual item performance requirements for device classes D, E, G, H, and K shall be in accordance with MIL-PRF-38534. Compliance with MIL-PRF-38534 shall include the performance of all tests herein or as designated in the device manufacturer's Quality Management (QM) plan or as designated for the applicable device class. The manufacturer may eliminate, modify or optimize the tests and inspections herein, however the performance requirements as defined in MIL-PRF-38534 shall be met for the applicable device class. In addition, the modification in the QM plan shall not affect the form, fit, or function of the device for the applicable device class.
- 3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38534 and herein.
 - 3.2.1 Case outline. The case outline shall be in accordance with 1.2.4 herein and figure 1.
 - 3.2.2 <u>Terminal connections</u>. The terminal connections shall be as specified on figure 2.
- 3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full specified operating temperature range.
- 3.4 <u>Electrical test requirements</u>. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are defined in table I.
- 3.5 <u>Marking of devices</u>. Marking of devices shall be in accordance with MIL-PRF-38534. The device shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's vendor similar PIN may also be marked.
- 3.6 <u>Data</u>. In addition to the general performance requirements of MIL-PRF-38534, the manufacturer of the device described herein shall maintain the electrical test data (variables format) from the initial quality conformance inspection group A lot sample, for each device type listed herein. Also, the data should include a summary of all parameters manually tested, and for those which, if any, are guaranteed. This data shall be maintained under document revision level control by the manufacturer and be made available to the preparing activity (DLA Land and Maritime-VA) upon request.
- 3.7 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to supply to this drawing. The certificate of compliance (original copy) submitted to DLA Land and Maritime-VA shall affirm that the manufacturer's product meets the performance requirements of MIL-PRF-38534 and herein.
- 3.8 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-PRF-38534 shall be provided with each lot of microcircuits delivered to this drawing.

4. VERIFICATION

4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with MIL-PRF-38534 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 4

	T	ABLE I. <u>Electrical performance</u>	characteristic	<u>3</u> .			
Test	Symbol	Conditions	Group A	Device	Limits		Unit
		$-55^{\circ}C \le T_C \le +85^{\circ}C$ V _{IN} = 28 V dc \pm 5%, C _L = 0 unless otherwise specified	subgroups	type	Min	Max	
Output voltage	V _{OUT}	I _{OUT} = 6 A	1 2, 3	01	4.95 4.90	5.05 5.10	V
Output current 1/	I _{OUT}	V _{IN} = 16, 28, 40 V dc	1, 2, 3	01		6	А
Output ripple voltage <u>2</u> /	V _{RiP}	V _{IN} = 18, 28, 40 V dc I _{OUT} = 6 A, BW = 20 Hz to 2 MHz	1, 2, 3	01		50	mV p-p
Line regulation	VR _{LINE}	V _{IN} = 18, 28, 40 V dc I _{OUT} = 0, 3, and 6 A	1, 2, 3	01	-0.5	+0.5	%
Load regulation	VR _{LOAD}	V _{IN} = 18, 28, 40 V dc I _{OUT} = 0, 3, and 6 A	1, 2, 3	01	-1.0	+1.0	%
Input current	I _{IN}	I _{OUT} = 0 A, pin 4 open	1, 2, 3	01		70	mA
		Pin 4 shorted to pin 2	1, 2, 3	01		8	mA
Efficiency	E _{FF}	I _{OUT} = 6 A	1, 2, 3	01	78		%
Isolation	ISO	Input to output or any pin to case except pin 3 at 500 V dc, T _C = +25°C	1	01	100		ΜΩ
Maximum capacitive load <u>3</u> / <u>4</u> /	C _L	I _{OUT} = 6 A, T _C = +25°C	1	01		50	μF
Power dissipation load fault	P _D	Short circuit, Overload	1, 2, 3	01		14	W
Current limit point	I _{LIM}	V _{OUT} = 90% of nominal	4, 5, 6	01	105	145	%
Switching frequency	F _S	100% load	4, 5, 6	01	425	575	kHz
Line rejection <u>3</u> /	REJ	100% load, DC to 50 kHz , T _C = +25°C	1	01	35		dB

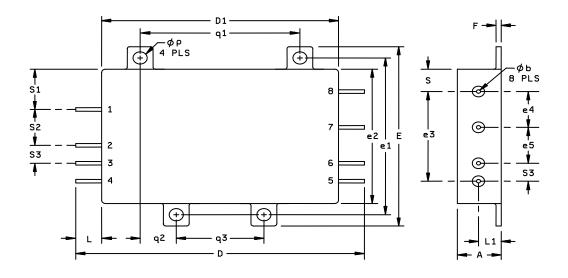
See footnotes at end of table.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 5

TABLE I. <u>Electrical performance characteristics</u> - Continued.								
Test	Symbol	Conditions	Group A	Device	Limits		Unit	
		$-55^{\circ}C \leq T_{C} \leq +85^{\circ}C$ $V_{IN} = 28V \ dc \pm 5\%, \ C_{L} = 0$ unless otherwise specified	subgroups	type	Min	Max		
Output response to step load changes <u>5</u> /	V _{TLD}	50% to/from 100% load	4, 5, 6	01	-300	300	mV pk	
Recovery time, step load changes <u>5</u> / <u>6</u> /	T _{TLD}	50% to/from 100% load	4, 5, 6	01		200	μS	
Output response to step line changes 3/7/	V _{TLN}	Input step 18 V to/from 40 V, I _{OUT} = 6 A	4, 5, 6	01	-300	300	mV pk	
Recovery time, step line changes 3/ 6/ 7/	T _{TLN}	Input step 18 V to/from 40 V, I _{OUT} = 6 A	4, 5, 6	01		200	μs	
Turn-on overshoot	V _{OS}	10% load, 100% load	4, 5, 6	01		500	mV	
Turn-on delay <u>8</u> /	T _{DLY}	10% load, 100% load	4, 5, 6	01		10	ms	

- 1/ Parameter verified during line and load regulation tests.
- 2/ Guaranteed for a DC to 2 MHz bandwidth. Tested using a 20 kHz to 2 MHz bandwidth.
- 3/ Parameter is tested as part of design characterization or after design changes. Thereafter, parameter shall be guaranteed to the limits specified in table I for all lots not specifically tested.
- 4/ Capacitive load may be any value from 0 to the maximum without compromising DC performance.
- $\underline{5}$ / Load step transition time ≤ 10 microseconds.
- $\underline{6}$ / Recovery time is measured from the initiation of the transient to where V_{OUT} has returned to within $\pm 1\%$ of its steady state value at 50% load.
- $\underline{7}$ / Line step transition time ≤ 100 microseconds.
- 8/ Turn-on delay time from either a step application of input power or a logic low to logic high transition on the inhibit pin while power is applied to the input.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 6



	Millimeters		Inc	hes
Symbol	Min	Max	Min	Max
Α		10.80		.425
D	70.87	71.37	2.79	2.81
D1	58.29	58.55	2.295	2.305
E	50.67	50.93	1.995	2.005
e1	44.32	44.58	1.745	1.755
e2	37.97	38.23	1.495	1.505
e3	25.27	25.53	.995	1.005
e4	10.03	10.29	.395	.405
e5	10.03	10.29	.395	.405
F	1.14	1.40	.045	.055
L	6.22	6.48	.245	.255
L1	5.46	5.72	.215	.225
q1	39.24	39.50	1.545	1.555
q2	8.76	9.02	.345	.355
q3	21.46	21.72	.845	.855
S	6.73	6.99	.265	.275
s1	11.81	12.07	.465	.475
s2	10.03	10.29	.395	.405
s3	4.95	5.21	.195	.205
Øb	0.89	1.14	.035	.045
Øp	3.38	3.63	.133	.143

NOTES:

- 1. The US government preferred system of measurement is the metric SI. This item was designed using inch-pound units of measurement. In case of problems involving conflicts between the metric and inch-pound units, the inch-pound units shall rule.
- 2. Case outline weight: 85 grams maximum.

FIGURE 1. Case outline.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 7

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Device type	01	
Terminal number	Terminal symbol	
1	Positive input	
2	Input return	
3	Case ground	
4	Enable	
5	Output adjust	
6	Output return	
7	Positive output	
8	No connection	

FIGURE 2. <u>Terminal connections</u>.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 8

TABLE II. Electrical test requirements.

MIL-PRF-38534 test requirements	Subgroups (in accordance with MIL-PRF-38534, group A test table)
Interim electrical parameters	
Final electrical parameters	1*, 2, 3, 4, 5, 6
Group A test requirements	1, 2, 3, 4, 5, 6
Group C end-point electrical parameters <u>1</u> /	1, 2, 3, 4
End-point electrical parameters for Radiation Hardness Assurance (RHA) devices	Not applicable

- * PDA applies to subgroup 1.
- 1/ As a minimum, for all Group C testing performed after 10 February 2011 manufacturers shall perform subgroups 1, 2, and 3 from the Group A electrical test table (Table C-Xa of MIL-PRF-38534).
- 4.2 Screening. Screening shall be in accordance with MIL-PRF-38534. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to either DLA Land and Maritime-VA or the acquiring activity upon request. Also, the test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1015 of MIL-STD-883.
 - (2) T_A as specified in accordance with table I of method 1015 of MIL-STD-883.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 <u>Conformance and periodic inspections</u>. Conformance inspection (CI) and periodic inspection (PI) shall be in accordance with MIL-PRF-38534 and as specified herein.
 - 4.3.1 Group A inspection (CI). Group A inspection shall be in accordance with MIL-PRF-38534 and as follows:
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 7, 8, 9, 10, and 11 shall be omitted.
 - 4.3.2 Group B inspection (PI). Group B inspection shall be in accordance with MIL-PRF-38534.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990		REVISION LEVEL A	SHEET 9

- 4.3.3 Group C inspection (PI). Group C inspection shall be in accordance with MIL-PRF-38534 and as follows:
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to either DLA Land and Maritime-VA or the acquiring activity upon request. Also, the test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1005 of MIL-STD-883.
 - (2) T_A as specified in accordance with table I of method 1005 of MIL-STD-883.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.
- 4.3.4 Group D inspection (PI). Group D inspection shall be in accordance with MIL-PRF-38534.
- 4.3.5 Radiation Hardness Assurance (RHA) inspection. RHA inspection is not currently applicable to this drawing.
- 5. PACKAGING
- 5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-PRF-38534.
- 6. NOTES
- 6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.
- 6.2 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 <u>Configuration control of SMD's</u>. All proposed changes to existing SMD's will be coordinated as specified in MIL-PRF-38534.
- 6.4 <u>Record of users</u>. Military and industrial users shall inform DLA Land and Maritime when a system application requires configuration control and the applicable SMD. DLA Land and Maritime will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronic devices (FSC 5962) should contact DLA Land and Maritime-VA, telephone (614) 692-0547.
- 6.5 <u>Comments</u>. Comments on this drawing should be directed to DLA Land and Maritime-VA, Columbus, Ohio 43218-3990, or telephone (614) 692-1081.
- 6.6 <u>Sources of supply</u>. Sources of supply are listed in MIL-HDBK-103 and QML-38534. The vendors listed in MIL-HDBK-103 and QML-38534 have submitted a certificate of compliance (see 3.7 herein) to DLA Land and Maritime-VA and have agreed to this drawing.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-05240
DLA LAND AND MARITIME		REVISION LEVEL	SHEET
COLUMBUS, OHIO 43218-3990		A	10

STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 11-02-10

Approved sources of supply for SMD 5962-05240 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38534 during the next revisions. MIL-HDBK-103 and QML-38534 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DLA Land and Maritime-VA. This information bulletin is superseded by the next dated revisions of MIL-HDBK-103 and QML-38534. DLA Land and Maritime maintains an online database of all current sources of supply at http://www.dscc.dla.mil/Programs/Smcr/.

Standard	Vendor	Vendor
microcircuit drawing	CAGE	similar
PIN <u>1</u> /	number	PIN <u>2</u> /
5962-0524001KXA	52467	LS2805S
5962-0524001KXC	52467	LS2805S

- 1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the Vendor to determine its availability.
- 2/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE __number_

Vendor name and address

52467

International Rectifier Corporation DBA Customer Services Department 2520 Junction Avenue San Jose, CA 95134-1902

The information contained herein is disseminated for convenience only and the Government assumes no liability whatsoever for any inaccuracies in the information bulletin.